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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

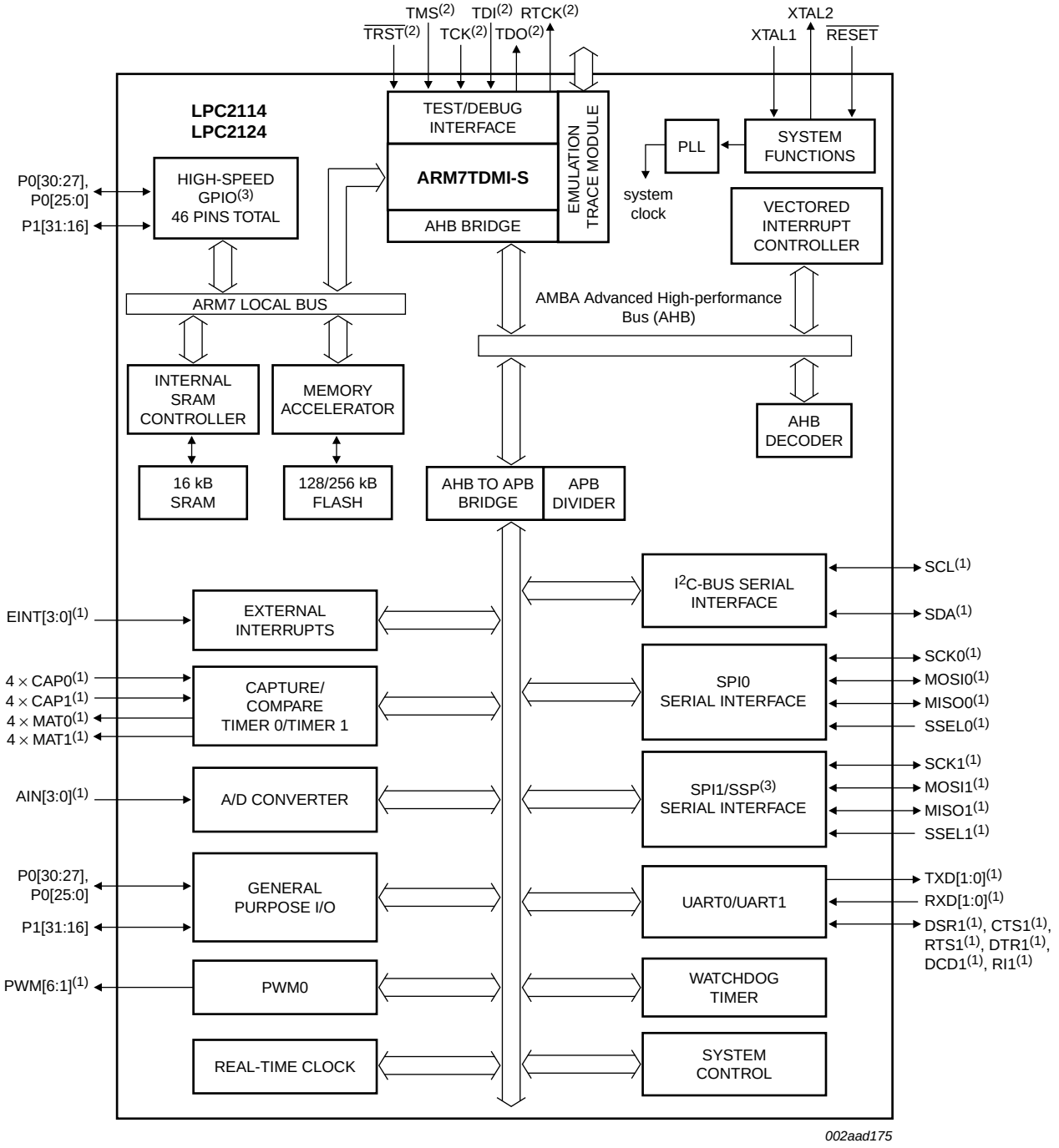
Details	
Product Status	Obsolete
Core Processor	ARM7®
Core Size	16/32-Bit
Speed	60MHz
Connectivity	I²C, Microwire, SPI, SSI, SSP, UART/USART
Peripherals	POR, PWM, WDT
Number of I/O	46
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	1.65V ~ 3.6V
Data Converters	A/D 4x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/lpc2114fbd64-151

3.1 Ordering options

Table 2. Ordering options

Type number	Flash memory	RAM	Fast GPIO/SSP/ Enhanced UART, ADC, Timer	Temperature range
LPC2114FBD64/01	128 kB	16 kB	yes	−40 °C to +85 °C
LPC2124FBD64/01	256 kB	16 kB	yes	−40 °C to +85 °C

4. Block diagram



(1) Shared with GPIO.

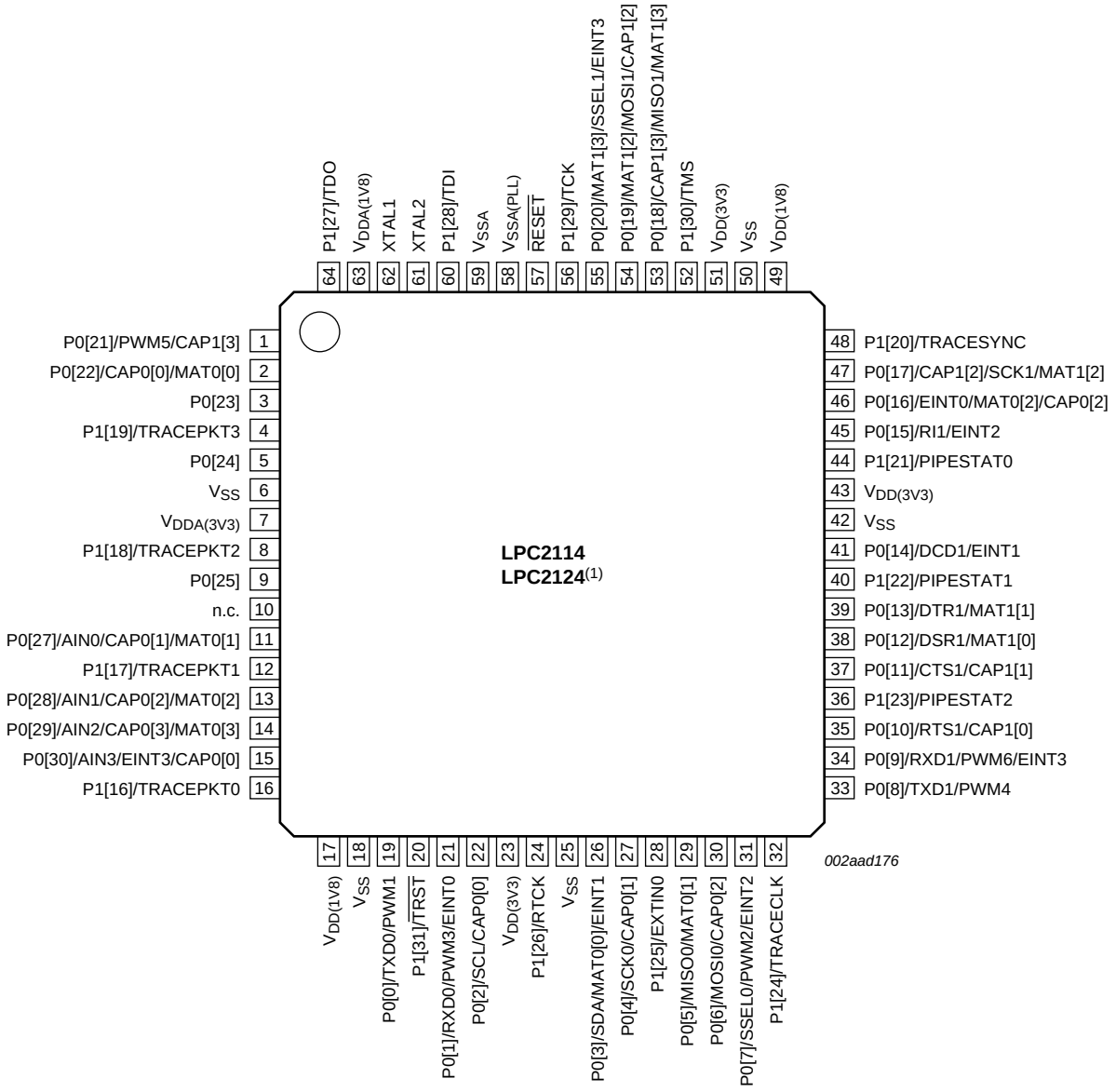
(2) When test/debug interface is used, GPIO/other functions sharing these pins are not available.

(3) SSP interface and high-speed GPIO are available on LPC2114/01 and LPC2124/01 only.

Fig 1. Block diagram

5. Pinning information

5.1 Pinning



(1) Pin configuration is identical for devices with and without the /00 and /01 suffixes.

Fig 2. Pin configuration

5.2 Pin description

Table 3. Pin description

Symbol	Pin	Type	Description
P0[0] to P0[31]		I/O	Port 0 is a 32-bit bidirectional I/O port with individual direction controls for each bit. The operation of port 0 pins depends upon the pin function selected via the Pin Connect Block. Pins 26 and 31 of port 0 are not available.
P0[0]/TXD0/ PWM1	19	O	**TXD0 —** Transmitter output for UART0.
		O	**PWM1 —** Pulse Width Modulator output 1.
P0[1]/RXD0/ PWM3/EINT0	21	I	**RXD0 —** Receiver input for UART0.
		O	**PWM3 —** Pulse Width Modulator output 3.
		I	**EINT0 —** External interrupt 0 input
P0[2]/SCL/ CAP0[0]	22	I/O	**SCL —** I^2C-bus clock input/output. Open-drain output (for I^2C-bus compliance).
		I	**CAP0[0] —** Capture input for Timer 0, channel 0.
P0[3]/SDA/ MAT0[0]/EINT1	26	I/O	**SDA —** I^2C-bus data input/output. Open-drain output (for I^2C-bus compliance).
		O	**MAT0[0] —** Match output for Timer 0, channel 0.
		I	**EINT1 —** External interrupt 1 input.
P0[4]/SCK0/ CAP0[1]	27	I/O	**SCK0 —** Serial clock for SPI0. SPI clock output from master or input to slave.
		I	**CAP0[1] —** Capture input for Timer 0, channel 1.
P0[5]/MISO0/ MAT0[1]	29	I/O	**MISO0 —** Master In Slave OUT for SPI0. Data input to SPI master or data output from SPI slave.
		O	**MAT0[1] —** Match output for Timer 0, channel 1.
P0[6]/MOSI0/ CAP0[2]	30	I/O	**MOSI0 —** Master Out Slave In for SPI0. Data output from SPI master or data input to SPI slave.
		I	**CAP0[2] —** Capture input for Timer 0, channel 2.
P0[7]/SSEL0/ PWM2/EINT2	31	I	**SSEL0 —** Slave Select for SPI0. Selects the SPI interface as a slave.
		O	**PWM2 —** Pulse Width Modulator output 2.
		I	**EINT2 —** External interrupt 2 input.
P0[8]/TXD1/ PWM4	33	O	**TXD1 —** Transmitter output for UART1.
		O	**PWM4 —** Pulse Width Modulator output 4.
P0[9]/RXD1/ PWM6/EINT3	34	I	**RXD1 —** Receiver input for UART1.
		O	**PWM6 —** Pulse Width Modulator output 6.
		I	**EINT3 —** External interrupt 3 input.
P0[10]/RTS1/ CAP1[0]	35	O	**RTS1 —** Request to Send output for UART1.
		I	**CAP1[0] —** Capture input for Timer 1, channel 0.
P0[11]/CTS1/ CAP1[1]	37	I	**CTS1 —** Clear to Send input for UART1.
		I	**CAP1[1] —** Capture input for Timer 1, channel 1.
P0[12]/DSR1/ MAT1[0]	38	I	**DSR1 —** Data Set Ready input for UART1.
		O	**MAT1[0] —** Match output for Timer 1, channel 0.
P0[13]/DTR1/ MAT1[1]	39	O	**DTR1 —** Data Terminal Ready output for UART1.
		O	**MAT1[1] —** Match output for Timer 1, channel 1.
P0[14]/DCD1/ EINT1	41	I	**DCD1 —** Data Carrier Detect input for UART1.
		I	**EINT1 —** External interrupt 1 input. **Note:** LOW on this pin while $\overline{\text{RESET}}$ is LOW forces on-chip bootloader to take control of the part after reset.

Table 3. Pin description *…continued*

Symbol	Pin	Type	Description
P0[15]/RI1/EINT2	45	I	**RI1 —** Ring Indicator input for UART1.
		I	**EINT2 —** External interrupt 2 input.
P0[16]/EINT0/ MAT0[2]/CAP0[2]	46	I	**EINT0 —** External interrupt 0 input.
		O	**MAT0[2] —** Match output for Timer 0, channel 2.
		I	**CAP0[2] —** Capture input for Timer 0, channel 2.
P0[17]/CAP1[2]/ SCK1/MAT1[2]	47	I	**CAP1[2] —** Capture input for Timer 1, channel 2.
		I/O	**SCK1 —** Serial Clock for SPI1/SSP[1]. SPI clock output from master or input to slave.
		O	**MAT1[2] —** Match output for Timer 1, channel 2.
P0[18]/CAP1[3]/ MISO1/MAT1[3]	53	I	**CAP1[3] —** Capture input for Timer 1, channel 3.
		I/O	**MISO1 —** Master In Slave Out for SPI1/SSP[1]. Data input to SPI master or data output from SPI slave.
		O	**MAT1[3] —** Match output for Timer 1, channel 3.
P0[19]/MAT1[2]/ MOSI1/CAP1[2]	54	O	**MAT1[2] —** Match output for Timer 1, channel 2.
		I/O	**MOSI1 —** Master Out Slave In for SPI1/SSP[1]. Data output from SPI master or data input to SPI slave.
		I	**CAP1[2] —** Capture input for Timer 1, channel 2.
P0[20]/MAT1[3]/ SSEL1/EINT3	55	O	**MAT1[3] —** Match output for Timer 1, channel 3.
		I	**SSEL1 —** Slave Select for SPI1/SSP[1]. Selects the SPI interface as a slave.
		I	**EINT3 —** External interrupt 3 input.
P0[21]/PWM5/ CAP1[3]	1	O	**PWM5 —** Pulse Width Modulator output 5.
		I	**CAP1[3] —** Capture input for Timer 1, channel 3.
P0[22]/CAP0[0]/ MAT0[0]	2	I	**CAP0[0] —** Capture input for Timer 0, channel 0.
		O	**MAT0[0] —** Match output for Timer 0, channel 0.
P0[23]	3	I/O	general purpose bidirectional digital port only
P0[24]	5	I/O	general purpose bidirectional digital port only
P0[25]	9	I/O	general purpose bidirectional digital port only
P0[27]/AIN0/ CAP0[1]/MAT0[1]	11	I	**AIN0 —** ADC, input 0. This analog input is always connected to its pin.
		I	**CAP0[1] —** Capture input for Timer 0, channel 1.
		O	**MAT0[1] —** Match output for Timer 0, channel 1.
P0[28]/AIN1/ CAP0[2]/MAT0[2]	13	I	**AIN1 —** ADC, input 1. This analog input is always connected to its pin.
		I	**CAP0[2] —** Capture input for Timer 0, channel 2.
		O	**MAT0[2] —** Match output for Timer 0, channel 2.
P0[29]/AIN2/ CAP0[3]/MAT0[3]	14	I	**AIN2 —** ADC, input 2. This analog input is always connected to its pin.
		I	**CAP0[3] —** Capture input for Timer 0, Channel 3.
		O	**MAT0[3] —** Match output for Timer 0, channel 3.
P0[30]/AIN3/ EINT3/CAP0[0]	15	I	**AIN3 —** ADC, input 3. This analog input is always connected to its pin.
		I	**EINT3 —** External interrupt 3 input.
		I	**CAP0[0] —** Capture input for Timer 0, channel 0.
P1[0] to P1[31]		I/O	Port 1 is a 32-bit bidirectional I/O port with individual direction controls for each bit. The operation of port 1 pins depends upon the pin function selected via the Pin Connect Block. Pins 0 through 15 of port 1 are not available.

Table 3. Pin description *…continued*

Symbol	Pin	Type	Description
$V_{DDA(1V8)}$	63	I	analog 1.8 V core power supply; this is the power supply voltage for internal circuitry. This should be nominally the same voltage as $V_{DD(1V8)}$ but should be isolated to minimize noise and error.
$V_{DD(3V3)}$	23, 43, 51	I	3.3 V pad power supply; this is the power supply voltage for the I/O ports
$V_{DDA(3V3)}$	7	I	analog 3.3 V pad power supply; this should be nominally the same voltage as $V_{DD(3V3)}$ but should be isolated to minimize noise and error

[1] SSP interface available on LPC2114/01 and LPC2124/01 only.

However, the ISP flash erase command can be executed at any time (no matter whether the CRP is on or off). Removal of CRP is achieved by erasure of full on-chip user flash. With the CRP off, full access to the chip via the JTAG and/or ISP is restored.

6.3 On-chip static RAM

On-chip static RAM may be used for code and/or data storage. The SRAM may be accessed as 8 bit, 16 bit, and 32 bit. The LPC2114/2124 provide 16 kB of static RAM.

6.4 Memory map

The LPC2114/2124 memory maps incorporate several distinct regions, as shown in Figure 3.

In addition, the CPU interrupt vectors may be re-mapped to allow them to reside in either flash memory (the default) or on-chip static RAM. This is described in Section 6.17 “System control”.

Table 4. Interrupt sources *…continued*

Block	Flag(s)	VIC channel #
System Control	External Interrupt 0 (EINT0)	14
	External Interrupt 1 (EINT1)	15
	External Interrupt 2 (EINT2)	16
	External Interrupt 3 (EINT3)	17
ADC	ADC	18

[1] SSP interface available on LPC2114/01 and LPC2124/01 only.

6.6 Pin connect block

The pin connect block allows selected pins of the microcontroller to have more than one function. Configuration registers control the multiplexers to allow connection between the pin and the on chip peripherals. Peripherals should be connected to the appropriate pins prior to being activated, and prior to any related interrupt(s) being enabled. Activity of any enabled peripheral function that is not mapped to a related pin should be considered undefined.

6.7 General purpose parallel I/O (GPIO) and Fast I/O

Device pins that are not connected to a specific peripheral function are controlled by the parallel I/O registers. Pins may be dynamically configured as inputs or outputs. Separate registers allow setting or clearing any number of outputs simultaneously. The value of the output register may be read back, as well as the current state of the port pins.

6.7.1 Features

- Bit-level set and clear registers allow a single instruction set or clear of any number of bits in one port.
- Direction control of individual bits.
- Separate control of output set and clear.
- All I/O default to inputs after reset.

6.7.2 Features added with the Fast GPIO set of registers available on LPC2114/2124/01 only

- Fast GPIO registers are relocated to the ARM local bus for the fastest possible I/O timing, enabling port pin toggling up to 3.5 times faster than earlier LPC2000 devices.
- Mask registers allow treating sets of port bits as a group, leaving other bits unchanged.
- All Fast GPIO registers are byte addressable.
- Entire port value can be written in one instruction.
- Ports are accessible via either the legacy group of registers (GPIOs) or the group of registers providing accelerated port access (Fast GPIOs).

6.8 10-bit ADC

The LPC2114/2124 each contain a single 10-bit successive approximation analog to digital converter with four multiplexed channels.

the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either master or slave mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I^2C-bus is a multi-master bus; it can be controlled by more than one bus master connected to it.

The I^2C-bus implemented in LPC2114/2124 supports a bit rate up to 400 kbit/s (Fast I^2C-bus).

6.10.1 Features

- Standard I^2C-bus compliant interface.
- Easy to configure as Master, Slave, or Master/Slave.
- Programmable clocks allow versatile rate control.
- Bidirectional data transfer between masters and slaves.
- Multi-master bus (no central master).
- Arbitration between simultaneously transmitting masters without corruption of serial data on the bus.
- Serial clock synchronization allows devices with different bit rates to communicate via one serial bus.
- Serial clock synchronization can be used as a handshake mechanism to suspend and resume serial transfer.
- The I^2C-bus may be used for test and diagnostic purposes.

6.11 SPI serial I/O controller

The LPC2114/2124 each contain two SPIs. The SPI is a full duplex serial interface, designed to be able to handle multiple masters and slaves connected to a given bus. Only a single master and a single slave can communicate on the interface during a given data transfer. During a data transfer the master always sends a byte of data to the slave, and the slave always sends a byte of data to the master.

6.11.1 Features

- Compliant with Serial Peripheral Interface (SPI) specification.
- Synchronous, Serial, Full Duplex communication.
- Combined SPI master and slave.
- Maximum data bit rate of $\frac{1}{8}$ of the input clock rate.

6.11.2 Features available in LPC2114/2124/01 only

- Eight to 16 bits per frame.
- When the SPI interface is used in Master mode, the SSELn pin is not needed (can be used for a different function).

6.13.2 Features available in LPC2114/2124/01 only

- Timer can count cycles of either the peripheral clock (PCLK) or an externally supplied clock.
- When counting cycles of an externally supplied clock only one of timer's capture inputs can be selected as the timer's clock. The rate of such a clock is limited to PCLK / 4. Duration of HIGH/LOW levels on the selected CAPn input can not be shorter than 1 / (2PCLK).

6.14 Watchdog timer

The purpose of the watchdog is to reset the microcontroller within a reasonable amount of time if it enters an erroneous state. When enabled, the watchdog will generate a system reset if the user program fails to 'feed' (or reload) the watchdog within a predetermined amount of time.

6.14.1 Features

- Internally resets chip if not periodically reloaded.
- Debug mode.
- Enabled by software but requires a hardware reset or a watchdog reset/interrupt to be disabled.
- Incorrect/incomplete feed sequence causes reset/interrupt if enabled.
- Flag to indicate watchdog reset.
- Programmable 32-bit timer with internal pre-scaler.
- Selectable time period from ($T_{cy(PCLK)} \times 256 \times 4$) to ($T_{cy(PCLK)} \times 2^{32} \times 4$) in multiples of $T_{cy(PCLK)} \times 4$.

6.15 Real-time clock

The RTC is designed to provide a set of counters to measure time when normal or idle operating mode is selected. The RTC has been designed to use little power, making it suitable for battery powered systems where the CPU is not running continuously (Idle mode).

6.15.1 Features

- Measures the passage of time to maintain a calendar and clock.
- Ultra low power design to support battery powered systems.
- Provides Seconds, Minutes, Hours, Day of Month, Month, Year, Day of Week, and Day of Year.
- Programmable reference clock divider allows adjustment of the RTC to match various crystal frequencies.

6.16 Pulse width modulator

The PWM is based on the standard Timer block and inherits all of its features, although only the PWM function is pinned out on the LPC2114/2124. The Timer is designed to count cycles of the peripheral clock (PCLK) and optionally generate interrupts or perform other actions when specified timer values occur, based on seven match registers. The PWM function is also based on match register events.

The ability to separately control rising and falling edge locations allows the PWM to be used for more applications. For instance, multi-phase motor control typically requires three non-overlapping PWM outputs with individual control of all three pulse widths and positions.

Two match registers can be used to provide a single edge controlled PWM output. One match register (MR0) controls the PWM cycle rate, by resetting the count upon match. The other match register controls the PWM edge position. Additional single edge controlled PWM outputs require only one match register each, since the repetition rate is the same for all PWM outputs. Multiple single edge controlled PWM outputs will all have a rising edge at the beginning of each PWM cycle, when an MR0 match occurs.

Three match registers can be used to provide a PWM output with both edges controlled. Again, the MR0 match register controls the PWM cycle rate. The other match registers control the two PWM edge positions. Additional double edge controlled PWM outputs require only two match registers each, since the repetition rate is the same for all PWM outputs.

With double edge controlled PWM outputs, specific match registers control the rising and falling edge of the output. This allows both positive going PWM pulses (when the rising edge occurs prior to the falling edge), and negative going PWM pulses (when the falling edge occurs prior to the rising edge).

6.16.1 Features

- Seven match registers allow up to six single edge controlled or three double edge controlled PWM outputs, or a mix of both types.
- The match registers also allow:
  - Continuous operation with optional interrupt generation on match.
  - Stop timer on match with optional interrupt generation.
  - Reset timer on match with optional interrupt generation.
- Supports single edge controlled and/or double edge controlled PWM outputs. Single edge controlled PWM outputs all go HIGH at the beginning of each cycle unless the output is a constant LOW. Double edge controlled PWM outputs can have either edge occur at any position within a cycle. This allows for both positive going and negative going pulses.
- Pulse period and width can be any number of timer counts. This allows complete flexibility in the trade-off between resolution and repetition rate. All PWM outputs will occur at the same repetition rate.
- Double edge controlled PWM outputs can be programmed to be either positive going or negative going pulses.

8. Static characteristics

Table 6. Static characteristics

T_{amb} = −40 °C to +85 °C for industrial applications, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
$V_{DD(1V8)}$	supply voltage (1.8 V)		[2]	1.65	1.8	1.95	V
$V_{DD(3V3)}$	supply voltage (3.3 V)		[3]	3.0	3.3	3.6	V
$V_{DDA(3V3)}$	analog supply voltage (3.3 V)			2.5	3.3	3.6	V
Standard port pins, $\overline{\text{RESET}}$, RTCK							
I_{IL}	LOW-state input current	V_I = 0 V; no pull-up		-	-	3	μA
I_{IH}	HIGH-state input current	$V_I = V_{DD(3V3)}$; no pull-down		-	-	3	μA
I_{OZ}	OFF-state output current	V_O = 0 V; $V_O = V_{DD(3V3)}$; no pull-up/down		-	-	3	μA
I_{latch}	I/O latch-up current	$-(0.5V_{DD(3V3)}) < V_I < (1.5V_{DD(3V3)})$; T_j < 125 °C		100	-	-	mA
V_I	input voltage		[4][5][6]	0	-	5.5	V
V_O	output voltage	output active		0	-	$V_{DD(3V3)}$	V
V_{IH}	HIGH-state input voltage			2.0	-	-	V
V_{IL}	LOW-state input voltage			-	-	0.8	V
V_{hys}	hysteresis voltage			0.4	-	-	V
V_{OH}	HIGH-state output voltage	I_{OH} = −4 mA	[7]	$V_{DD(3V3)} - 0.4$	-	-	V
V_{OL}	LOW-state output voltage	I_{OL} = 4 mA	[7]	-	-	0.4	V
I_{OH}	HIGH-state output current	$V_{OH} = V_{DD(3V3)} - 0.4$ V	[7]	−4	-	-	mA
I_{OL}	LOW-state output current	V_{OL} = 0.4 V	[7]	4	-	-	mA
I_{OHS}	HIGH-state short-circuit output current	V_{OH} = 0 V	[8]	-	-	−45	mA
I_{OLS}	LOW-state short-circuit output current	$V_{OL} = V_{DD(3V3)}$	[8]	-	-	50	mA
I_{pd}	pull-down current	V_I = 5 V	[9]	10	50	150	μA
I_{pu}	pull-up current	V_I = 0 V	[10]	−15	−50	−85	μA
		$V_{DD(3V3)} < V_I$ < 5 V	[9]	0	0	0	μA

Table 6. Static characteristics *…continued*

T_{amb} = −40 °C to +85 °C for industrial applications, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
Power consumption LPC2114, LPC2114/00, LPC2124, LPC2124/00							
$I_{DD(act)}$	active mode supply current	$V_{DD(1V8)}$ = 1.8 V; CCLK = 60 MHz; T_{amb} = 25 °C; code `while(1){}` executed from flash; all peripherals enabled via PCONP[11] register but not configured to run		-	60	-	mA
$I_{DD(pd)}$	Power-down mode supply current	$V_{DD(1V8)}$ = 1.8 V; T_{amb} = 25 °C		-	10	-	μA
		$V_{DD(1V8)}$ = 1.8 V; T_{amb} = 85 °C		-	110	500	μA
Power consumption LPC2114/01 and LPC2124/01							
$I_{DD(act)}$	active mode supply current	$V_{DD(1V8)}$ = 1.8 V; CCLK = 60 MHz; T_{amb} = 25 °C; code `while(1){}` executed from flash; all peripherals enabled via PCONP[11] register but not configured to run		-	40	-	mA
$I_{DD(idle)}$	Idle mode supply current	$V_{DD(1V8)}$ = 1.8 V; CCLK = 60 MHz; T_{amb} = 25 °C; executed from flash; all peripherals enabled via PCONP[11] register but not configured to run		-	6.5	-	mA
$I_{DD(pd)}$	Power-down mode supply current	$V_{DD(1V8)}$ = 1.8 V; T_{amb} = 25 °C		-	10	-	μA
		$V_{DD(1V8)}$ = 1.8 V; T_{amb} = 85 °C		-	110	500	μA
I^2C-bus pins							
V_{IH}	HIGH-state input voltage			$0.7V_{DD(3V3)}$	-	-	V
V_{IL}	LOW-state input voltage			-	-	$0.3V_{DD(3V3)}$	V
V_{hys}	hysteresis voltage			-	$0.05V_{DD(3V3)}$	-	V
V_{OL}	LOW-state output voltage	I_{OLS} = 3 mA	[7]	-	-	0.4	V
I_{LI}	input leakage current	$V_I = V_{DD(3V3)}$	[12]	-	2	4	μA
		V_I = 5 V		-	10	22	μA

Table 7. ADC static characteristics

V_{DDA} = 2.5 V to 3.6 V unless otherwise specified; T_{amb} = −40 °C to +85 °C unless otherwise specified. ADC frequency 4.5 MHz.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
V_{IA}	analog input voltage			0	-	V_{DDA}	V
C_{ia}	analog input capacitance			-	-	1	pF
E_D	differential linearity error		[1][2][3]	-	-	±1	LSB
$E_{L(adj)}$	integral non-linearity		[1][4]	-	-	±2	LSB
E_O	offset error		[1][5]	-	-	±3	LSB
E_G	gain error		[1][6]	-	-	±0.5	%
E_T	absolute error		[1][7]	-	-	±4	LSB

[1] Conditions: V_{SSA} = 0 V, V_{DDA} = 3.3 V.

[2] The ADC is monotonic, there are no missing codes.

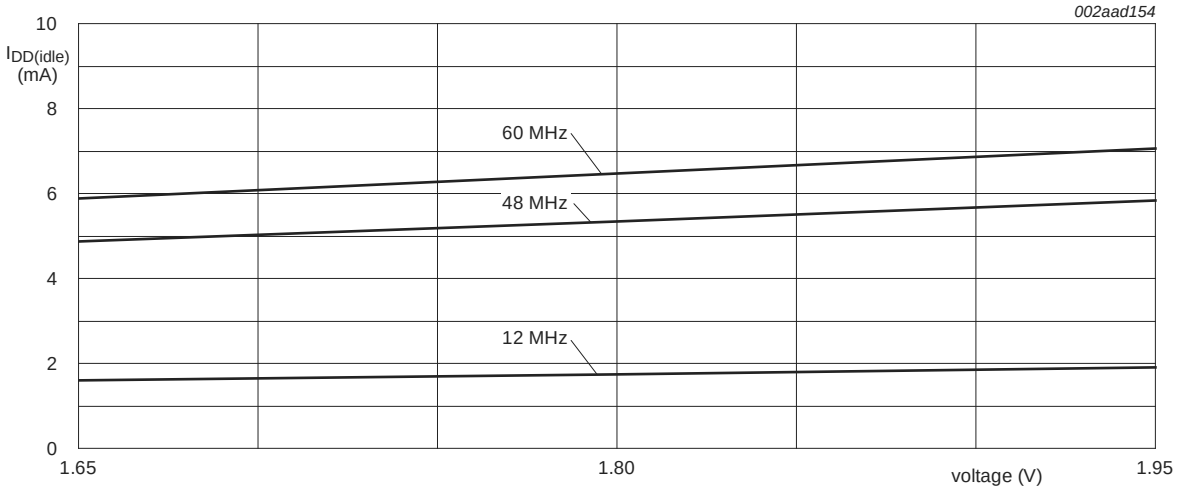
[3] The differential linearity error (E_D) is the difference between the actual step width and the ideal step width. See Figure 4.

[4] The integral non-linearity ($E_{L(adj)}$) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See Figure 4.

[5] The offset error (E_O) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See Figure 4.

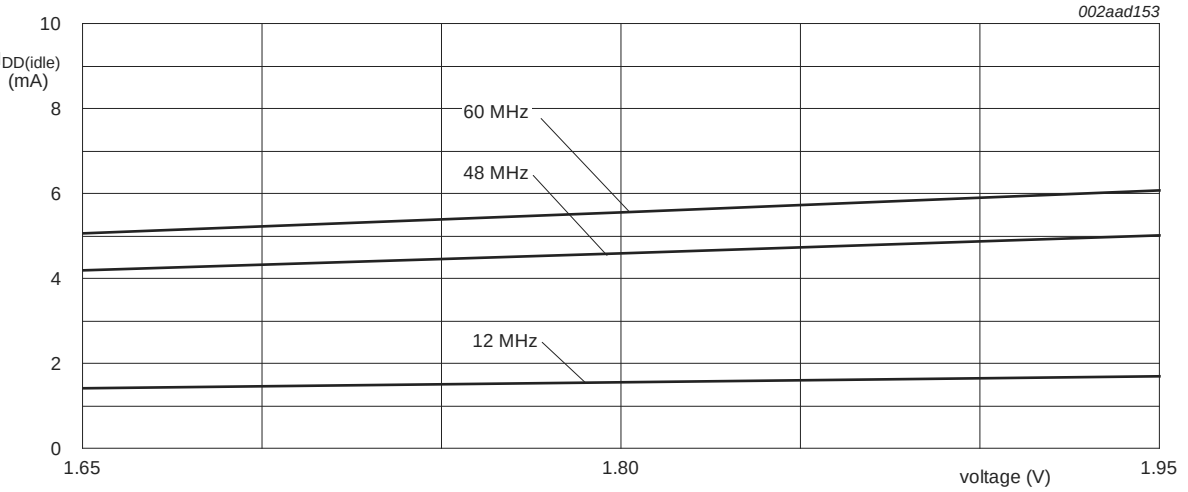
[6] The gain error (E_G) is the relative difference in percent between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See Figure 4.

[7] The absolute voltage error (E_T) is the maximum difference between the center of the steps of the actual transfer curve of the non-calibrated ADC and the ideal transfer curve. See Figure 4.



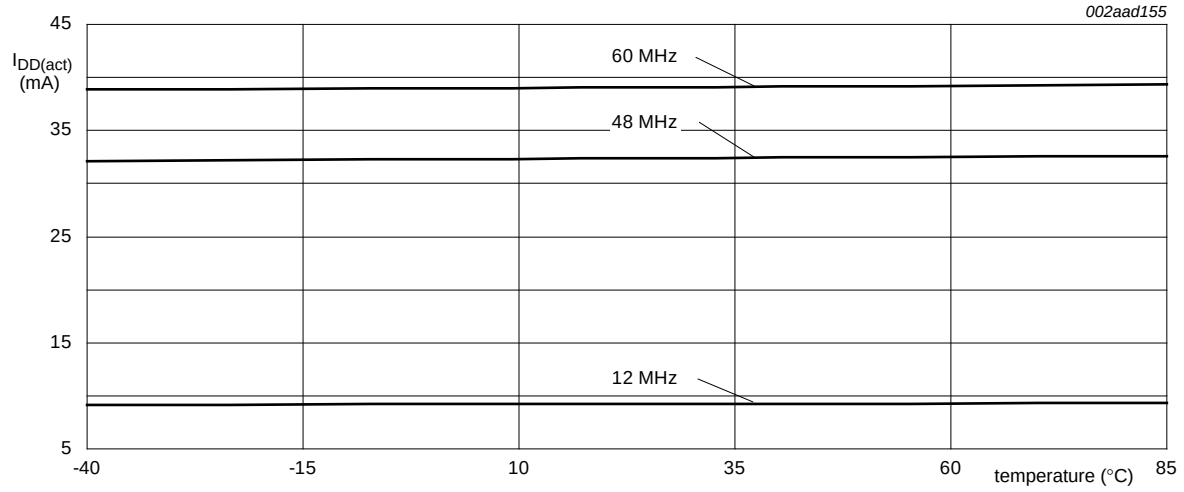
Test conditions: Idle mode entered executing code from on-chip flash; PCLK = $^{CCLK}/_{4}$;
T_{amb} = 25 °C; core voltage 1.8 V; all peripherals enabled.

Fig 9. Typical LPC2114/01 and LPC2124/01 $I_{DD(idle)}$ measured at different voltages



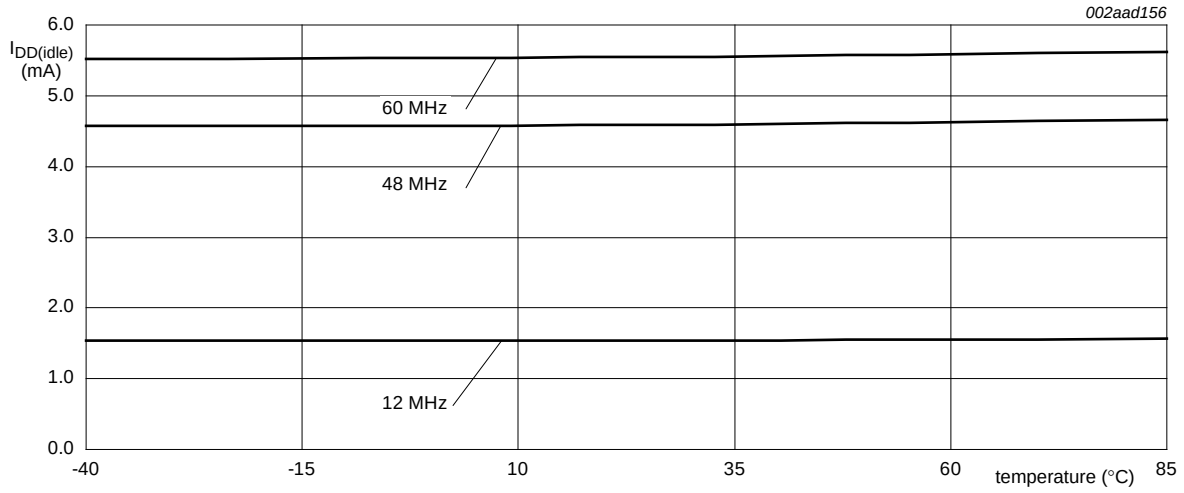
Test conditions: Idle mode entered executing code from on-chip flash; PCLK = $^{CCLK}/_{4}$;
Temp = 25 °C; core voltage 1.8 V; all peripherals disabled.

Fig 10. Typical LPC2114/01 and LPC2124/01 $I_{DD(idle)}$ measured at different voltages



Test conditions: Active mode entered executing code from on-chip flash; PCLK = $^{CCLK}/_{4}$; core voltage 1.8 V; all peripherals disabled.

Fig 11. Typical LPC2114/01 and LPC2124/01 $I_{DD(act)}$ measured at different temperatures



Test conditions: Idle mode entered executing code from on-chip flash; PCLK = $^{CCLK}/_{4}$; core voltage 1.8 V; all peripherals disabled.

Fig 12. Typical LPC2114/01 and LPC2124/01 $I_{DD(idle)}$ measured at different temperatures

9. Dynamic characteristics

Table 9. Dynamic characteristics

T_{amb} = −40 °C to +85 °C for industrial applications; $V_{DD(1V8)}$, $V_{DD(3V3)}$ over specified ranges.[1]

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
External clock						
f_{osc}	oscillator frequency	supplied by an external oscillator (signal generator)	1	-	50	MHz
		external clock frequency supplied by an external crystal oscillator	1	-	30	MHz
		external clock frequency if on-chip PLL is used	10	-	25	MHz
		external clock frequency if on-chip bootloader is used for initial code download	10	-	25	MHz
$T_{cy(clk)}$	clock cycle time		20	-	1000	ns
t_{CHCX}	clock HIGH time		$T_{cy(clk)} \times 0.4$	-	-	ns
t_{CLCX}	clock LOW time		$T_{cy(clk)} \times 0.4$	-	-	ns
t_{CLCH}	clock rise time		-	-	5	ns
t_{CHCL}	clock fall time		-	-	5	ns
Port pins (except P0[2] and P0[3])						
t_r	rise time		-	10	-	ns
t_f	fall time		-	10	-	ns
I^2C-bus pins (P0[2] and P0[3])						
t_f	fall time	V_{IH} to V_{IL}	[2] $20 + 0.1 \times C_b$	-	-	ns

[1] Parameters are valid over operating temperature range unless otherwise specified.

[2] Bus capacitance C_b in pF, from 10 pF to 400 pF.

9.1 Timing

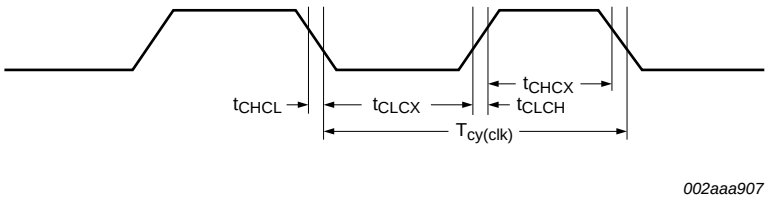


Fig 14. External clock timing (with an amplitude of at least $V_{i(RMS)}$ = 200 mV)

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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15. Contents

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Date of release: 10 June 2011
Document identifier: LPC2114_2124